TDA8024

Standard smart card interface

Rev. 4.0 — 3 June 2016

Product data sheet

1. General description

The TDA8024 is a complete and cost-efficient analog interface for asynchronous 3 V or 5 V smart cards. It can be placed between the card and the microcontroller to perform all supply, protection and control functions. Very few external components are required. The TDA8024AT is a direct replacement for the TDA8004AT.

More information can be obtained from the NXP internet site (<u>www.nxp.com</u>) and from "Application note AN10141".

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

2. Features and benefits

- IC card interface
- 3 V or 5 V supply for the IC (V_{DD} and GND)
- Three specifically protected half-duplex bidirectional buffered I/O lines to card contacts C4, C7 and C8
- DC-to-DC converter for V_{CC} generation separately powered from a 5 V \pm 20% supply (V_{DDP} and PGND)
- \blacksquare 3 V or 5 V \pm 5% regulated card supply voltage (V_{CC}) with appropriate decoupling has the following capabilities:
 - \bullet I_{CC} < 80 mA at V_{DDP} = 4 V to 6.5 V
 - Handles current spikes of 40 nAs up to 20 MHz
 - Controls rise and fall times
 - Filtered overload detection at approximately 120 mA
- Thermal and short-circuit protection on all card contacts
- Automatic activation and deactivation sequences; initiated by software or by hardware in the event of a short-circuit, card take-off, overheating, V_{DD} or V_{DDP} drop-out
- Enhanced ESD protection on card side (>6 kV)
- 26 MHz integrated crystal oscillator
- Clock generation for cards up to 20 MHz (divided by 1, 2, 4 or 8 through CLKDIV1 and CLKDIV2 signals) with synchronous frequency changes
- Non-inverted control of RST via pin RSTIN
- ISO 7816, GSM11.11 and EMV (payment systems) compatibility



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- Supply supervisor for spike-killing during power-on and power-off and Power-on reset (threshold fixed internally or externally by a resistor bridge); not for TDA8024AT
- Built-in debounce on card presence contacts
- One multiplexed status signal OFF

3. Applications

- IC card readers for banking
- Electronic payment
- Identification
- Pay TV

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
Power supplies			·	·			
V_{DD}	supply voltage		2.7	-	6.5	V	
V_{DDP}	DC-to-DC converter	V _{CC} = 5 V; I _{CC} < 80 mA	4.0	5.0	6.5	V	
	supply voltage	$V_{CC} = 5 \text{ V}; I_{CC} < 20 \text{ mA}$	3.0	-	6.5	V	
I_{DD}	supply current	V _{DD} = 3.3 V; f _{XTAL} = 10 MHz	·	·		·	
		card inactive	-	-	1.2	mA	
		card active; $f_{CLK} = f_{XTAL}$; $C_L = 30 \text{ pF}$	-	-	1.5	mA	
I _{DDP}	DC-to-DC converter	$V_{DDP} = 5 \text{ V}; f_{XTAL} = 10 \text{ MHz}$,				
	supply current	inactive mode	-	-	0.1	mA	
		active mode; $f_{CLK} = f_{XTAL}$; $C_L = 30 \text{ pF}$; $ I_{CC} = 0$	-	-	10	mA	
Card supply	'			'			
V _{CC}	card suppy voltage (including ripple voltage)	5 V card:					
		card active; I _{CC} < 80 mA DC	4.75	5.0	5.25	V	
		card active; current pulses I _p = 40 nAs	4.65	5.0	5.25	V	
		3 V card:					
		card active; I _{CC} < 65 mA DC	2.85	3.0	3.15	V	
		card active; current pulses I _p = 40 nAs	2.76	3.0	3.20	V	
V _{CC(ripple)(p-p)}	ripple voltage on V _{CC} (peak-to-peak value)	f _{ripple} = 20 kHz to 200 MHz	-	-	350	mV	
I _{cc}	card supply current	V _{CC} = 0 to 5 V	-	-	80	mA	
		$V_{CC} = 0$ to 3 V	-	-	65	mA	

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Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
General	·					
t _{de}	deactivation time		50	80	100	μS
P _{tot}	total power dissipation	continuous operation; T _{amb} = -25 to +85 °C	-	-	0.56	W
T _{amb}	ambient temperature		-25	-	+85	°C

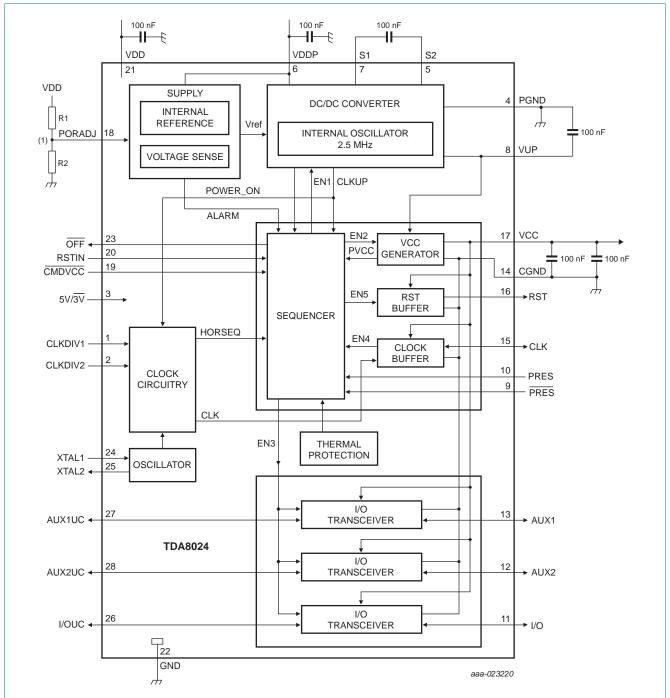
5. Ordering information

Table 2. Ordering information

Type number	Package					
	Name	Description	Version			
TDA8024T/C1	SO28	plastic small outline package; 28 leads; body width 7.5 mm	SOT136-1			
TDA8024AT/C1	SO28	plastic small outline package; 28 leads; body width 7.5 mm	SOT136-1			
TDA8024TT/C1	TSSOP28	plastic thin shrink small outline package; 28 leads; body width 4.4 mm, gold wires	SOT361-1			
TDA8024TT/C1/S1	TSSOP28	plastic thin shrink small outline package; 28 leads; body width 4.4 mm, copper wire	SOT361-1			

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6. Block diagram



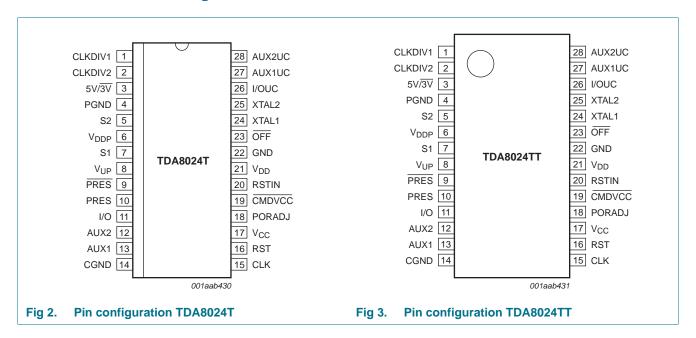
(1) Optional external resistor bridge. If this bridge is not required pin 18 should be connected to ground; see <u>Section 8.2.2</u>. Pin 18 is not connected in the TDA8024AT.

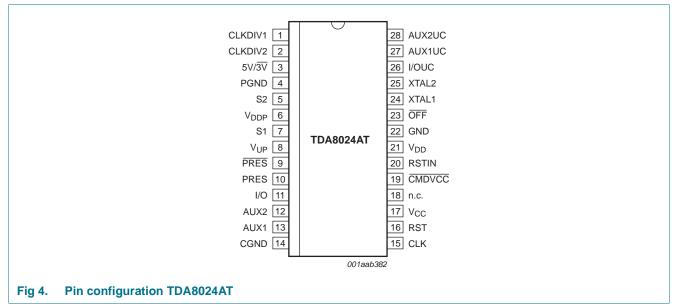
Fig 1. Block diagram

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7. Pinning information

7.1 Pinning





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7.2 Pin description

Table 3. Pin description

Symbol	Pin	Туре	Description	
CLKDIV1	1	I	CLK frequency selection input 1	
CLKDIV2	2	I	CLK frequency selection input 2	
5V/ 3V	3	I	card supply voltage selection input; V_{CC} = 5 V (HIGH) or V_{CC} = 3 V (LOW)	
PGND	4	S	DC-to-DC converter power supply ground	
S2	5	I/O	DC-to-DC converter capacitor; connected between pins S1 and S2; C = 100 nF with ESR < 100 m Ω	
V_{DDP}	6	S	DC-to-DC converter power supply voltage	
S1	7	I/O	DC-to-DC converter capacitor; connected between pins S1 and S2; C = 100 nF with ESR < 100 m Ω	
V_{UP}	8	I/O	DC-to-DC converter output decoupling capacitor connection C = 100 nF with ESR < 100 m Ω must be connected between V _{UP} and PGND	
PRES	9	I	card presence contact input (active LOW); if PRES or PRES is active, the card is considered 'present' and a built-in debounce feature of 8 ms (typ.) is activated	
PRES	10	I	card presence contact input (active HIGH); if PRES or PRES is active, the card is considered 'present' and a built-in debounce feature of 8 ms (typ.) is activated	
I/O	11	I/O	data line to/from card reader contact C7; integrated 11 $k\Omega$ pull-up resistor to V_{CC}	
AUX2	12	I/O	data line to/from card reader contact C8; integrated 11 $k\Omega$ pull-up resistor to V_{CC}	
AUX1	13	I/O	data line to/from card reader contact C4; integrated 11 $k\Omega$ pull-up resistor to V_{CC}	
CGND	14	S	card signal ground	
CLK	15	I/O	card clock to/from card reader contact C3	
RST	16	0	card reset output from card reader contact C2	
V _{CC}	17	S	card supply voltage to card reader contact C1; decoupled to CGND via 2 \times 100 nF or 100 + 220 nF capacitors with ESR < 100 m $\Omega^{[1]}$	
PORADJ	18	I	Power-on reset threshold adjustment input for changing the reset threshold with an external resistor bridge; doubles the width of the POR pulse when used; this pin is not connected for the TDA8024AT	
CMDVCC	19	I	input from the host to start activation sequence (active LOW)	
RSTIN	20	I	card reset input from the host	
V_{DD}	21	S	supply voltage	
GND	22	S	ground	
OFF	23	0	NMOS interrupt output to the host (active LOW); 20 k Ω integrated pull-up resistor to V_{DD}	
XTAL1	24	I	crystal connection or input for external clock	

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Table 3. Pin description continue	Table 3.	Pin des	scription.	continue
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Symbol	Pin	Туре	Description
XTAL2	25	0	crystal connection (leave open-circuit if external clock source is used)
I/OUC	26	I/O	host data I/O line; integrated 11 k Ω pull-up resistor to V_{DD}
AUX1UC	27	I/O	auxiliary data line to/from the host; integrated 11 k Ω pull-up
AUX2UC	28	I/O	resistor to V _{DD}

^[1] The noise margin on V_{CC} will be higher with the 220 nF capacitor.

8. Functional description

Throughout this document it is assumed that the reader is familiar with ISO7816 terminology.

8.1 Power supply

The supply pins for the IC are V_{DD} and GND. V_{DD} should be in the range of 2.7 V to 6.5 V. All signals interfacing with the system controller are referred to V_{DD} , therefore V_{DD} should also supply the system controller. All card reader contacts remain inactive during power-on or power-off.

The internal circuits are maintained in the reset state until V_{DD} reaches $V_{th2} + V_{hys2}$ and for the duration of the internal Power-on reset pulse, t_W (see <u>Figure 5</u>). When V_{DD} falls below V_{th2} , an automatic deactivation of the contacts is performed.

A DC-to-DC converter is incorporated to generate the 5 V or 3 V card supply voltage (V_{CC}). The DC-to-DC converter should be supplied separately by V_{DDP} and PGND. Due to the possibility of large transient currents, the two 100 nF capacitors of the DC-to-DC converter should be located as near as possible to the IC and have an ESR less than 100 m Ω .

The DC-to-DC converter functions as a voltage doubler or a voltage follower according to the respective values of V_{CC} and V_{DDP} (both have thresholds with a hysteresis of 100 mV).

The DC-to-DC converter function changes as follows.

- V_{CC} = 5 V and V_{DDP} > 5.8 V; voltage follower
- V_{CC} = 5 V and V_{DDP} < 5.7 V; voltage doubler
- V_{CC} = 3 V and V_{DDP} > 4.1 V; voltage follower
- V_{CC} = 3 V and V_{DDP} < 4.0 V; voltage doubler.

Supply voltages V_{DD} and V_{DDP} may be applied to the IC in any sequence.

After powering the device, OFF remains LOW until CMDVCC is set HIGH.

During power off, OFF falls LOW when V_{DD} is below the falling threshold voltage.

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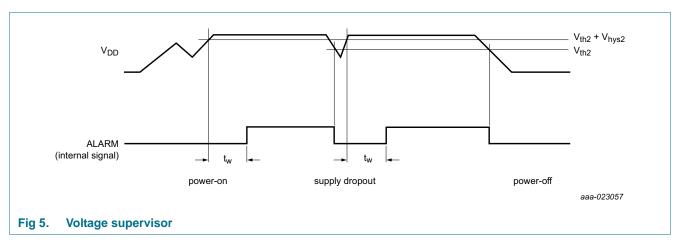
8.2 Voltage supervisor

8.2.1 Without external divider on pin PORADJ (or with TDA8024AT)

The voltage supervisor surveys the V_{DD} supply. A defined reset pulse of approximately 8 ms (t_W) is used internally to keep the IC inactive during power-on or power-off of the V_{DD} supply (see Figure 5).

As long as V_{DD} is less than $V_{th2} + V_{hys2}$, the IC remains inactive whatever the levels on the command lines. This state also lasts for the duration of t_W after V_{DD} has reached a level higher than $V_{th2} + V_{hys2}$.

When V_{DD} falls below V_{th2} , a deactivation sequence of the contacts is performed.



8.2.2 With an external divider on pin PORADJ (not for the TDA8024AT)

If an external resistor bridge is connected to pin PORADJ (R1 and R2 in <u>Figure 1</u>), then the following occurs:

 The internal threshold voltage V_{th2} is overridden by the external voltage and by the hysteresis, therefore:

$$V_{th2(ext)(rise)} = \left(1 + \frac{RI}{R2}\right) \times \left(V_{bridge} + \frac{V_{hys(ext)}}{2}\right)$$

$$V_{th2(ext)(fall)} = \left(1 + \frac{RI}{R2}\right) \times \left(V_{bridge} - \frac{V_{hys(ext)}}{2}\right)$$

where $V_{bridge} = 1.25 \text{ V typ.}$ and $V_{hys(ext)} = 60 \text{ mV typ.}$

• The reset pulse width t_W is doubled to approximately 16 ms.

Input PORADJ is biased internally with a pull-down current source of 4 μA which is removed when the voltage on pin PORADJ exceeds 1 V. This ensures that after detection of the external bridge by the IC during power-on, the input current on pin PORADJ does not cause inaccuracy of the bridge voltage.

The minimum threshold voltage should be higher than 2 V.

The maximum threshold voltage may be up to V_{DD}.

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8.2.3 Applications examples

The voltage supervisor is used as Power-on reset and as supply dropout detection during a card session.

Supply dropout detection is to ensure that a proper deactivation sequence is followed before the voltage is too low.

For the internal voltage supervisor to function, the system microcontroller should operate down to 2.35 V to ensure a proper deactivation sequence. If this is not possible, external resistor values can be chosen to overcome the problem.

8.2.3.1 Microcontroller requiring a 3.3 V \pm 20 % supply

For a microcontroller supplied by 3.3 V with a $\pm 5\%$ regulator and with resistors R1, R2 having a $\pm 1\%$ tolerance, the minimum supply voltage is 3.135 V.

 $V_{PORADJ} = k \times V_{DD}$, where $k = \frac{SI}{SI + S2}$ with S1 and S2 the actual values of nominal resistors R1 and R2.

This can be shown as:

$$0.99 \times R1 < S1 < 1.01 \times R1$$
 and $0.99 \times R2 < S2 < 1.01 \times R2$

Transposed, this becomes

$$1 + \left(0.98 \times \frac{RI}{R2}\right) = 1 + \left(\frac{0.99}{1.01}\right) \times \frac{R1}{R2} < \frac{1}{k}$$

$$\frac{1}{k} < 1 + \left(\frac{1.01}{0.99}\right) \times \frac{R1}{R2} = 1 + \left(1.02 \times \frac{R1}{R2}\right)$$

If V1 = $V_{th(ext)(rise)(max)}$ and V2 = $V_{th(ext)(fall)(min)}$ activation will always be possible if V_{PORADJ} > V1 and deactivation will always be done for V_{PORADJ} < V2.

Activation is always possible for $V_{DD} > \frac{VI}{k}$ and deactivation is always possible for $V_{DD} < \frac{V2}{k}$

That is V1 = 1.31 V and V2 = 1.19 V and
$$\frac{RI}{R2} < \left(\frac{3.135}{I.3I} - I\right) \times 0.98 = 1.365$$

Suppose R1 + R2 = 100 kΩ, then
$$R2 = \frac{100 \, k\Omega}{2.365} = 42.3 \, k\Omega$$
 and R1 = 57.7 kΩ.

Deactivation will be effective at $V2 \times (1 + 1.02 \times 1.365) = 2.847 \text{ V}$ in any case.

If the microcontroller continues to function down to 2.80 V, the slew rate on V_{DD} should be less than 2 V/ms to ensure that clock CLK is correctly delivered to the card until time t_{12} (see Figure 9).

8.2.3.2 Microcontroller requiring a 3.3 V \pm 10% supply

For a microcontroller supplied by a 3.3 V with a $\pm 1\%$ regulator and with resistors R1, R2 having a $\pm 0.1\%$ tolerance, the minimum supply voltage is 3.267 V.

The same calculations as in Section 8.2.3.1 conclude:

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$$\frac{R1}{R2} < \left(\frac{3.267}{1.310} - 1\right) \times 0.998 = 1.491$$

Therefor $R2 = \frac{100 \, k\Omega}{2.49} = 40.14 \, k\Omega$ and R1 = 59.86 k Ω .

Deactivation will be effective at $V2 \times (1 + 1.002 \times 1.491) = 2.967 \text{ V}$ in any case.

If the microcontroller continues to function down to 2.97 V, the slew rate on V_{DD} should be less than 0.20 V/ms to ensure that clock CLK is correctly delivered to the card until time t_{12} (see Figure 9).

8.3 Clock circuitry

The card clock signal (CLK) is derived from a clock signal input to pin XTAL1 or from a crystal operating at up to 26 MHz connected between pins XTAL1 and XTAL2.

The clock frequency can be f_{XTAL} , $\frac{1}{2} \times f_{XTAL}$, $\frac{1}{4} \times f_{XTAL}$ or $\frac{1}{8} \times f_{XTAL}$. Frequency selection is made via inputs CLKDIV1 and CLKDIV2 (see Table 4).

Table 4. Clock frequency selection[1]

CLKDIV1	CLKDIV2	f _{CLK}
0	0	$\frac{f_{XTAL}}{8}$
0	1	$\frac{f_{XTAL}}{4}$
1	1	$\frac{f_{XTAL}}{2}$
1	0	f_{XTAL}

^[1] The status of pins CLKDIV1 and CLKDIV2 must not be changed simultaneously; a delay of 10 ns minimum between changes is needed; the minimum duration of any state of CLK is eight periods of XTAL1.

The frequency change is synchronous, which means that during transition no pulse is shorter than 45% of the smallest period, and that the first and last clock pulses about the instant of change have the correct width.

When changing the frequency dynamically, the change is effective for only eight periods of XTAL1 after the command.

The duty factor of f_{XTAL} depends on the signal present at pin XTAL1.

In order to reach a 45% to 55% duty factor on pin CLK, the input signal on pin XTAL1 should have a duty factor of 48% to 52% and transition times of less than 5% of the input signal period.

If a crystal is used, the duty factor on pin CLK may be 45% to 55% depending on the circuit layout and on the crystal characteristics and frequency.

In other cases, the duty factor on pin CLK is guaranteed between 45% and 55% of the clock period.

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The crystal oscillator runs as soon as the IC is powered up. If the crystal oscillator is used, or if the clock pulse on pin XTAL1 is permanent, the clock pulse is applied to the card as shown in the activation sequences shown in Figure 7 and 8.

If the signal applied to XTAL1 is controlled by the system microcontroller, the clock pulse will be applied to the card when it is sent by the system microcontroller (after completion of the activation sequence).

8.4 I/O transceivers

The three data lines I/O, AUX1 and AUX2 are identical.

The Idle-state is realized by both I/O and I/OUC lines being pulled HIGH via a 11 $k\Omega$ resistor (I/O to V_{CC} and I/OUC to V_{DD}).

Pin I/O is referenced to V_{CC} , and pin I/OUC to V_{DD} , thus allowing operation when V_{CC} is not equal to V_{DD} .

The first side of the transceiver to receive a falling edge becomes the master. An anti-latch circuit disables the detection of falling edges on the line of the other side, which then becomes a slave.

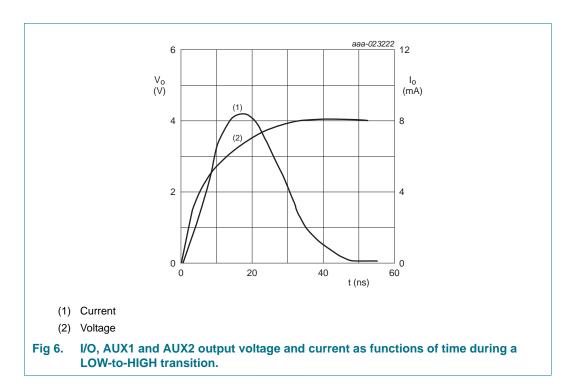
After a time delay $t_{d(edge)}$, an N-transistor on the slave side is turned on, thus transmitting the logic 0 present on the master side.

When the master side returns to logic 1, a P-transistor on the slave side is turned on during the time delay t_{pu} and then both sides return to their idle states.

This active pull-up feature ensures fast LOW-to-HIGH transitions; as shown in $\underline{\text{Figure 6}}$, it is able to deliver more than 1 mA at an output voltage of up to $0.9V_{CC}$ into an 80 pF load. At the end of the active pull-up pulse, the output voltage depends only on the internal pull-up resistor and the load current.

The current to and from the card I/O lines is limited internally to 15 mA and the maximum frequency on these lines is 1 MHz.

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8.5 Inactive mode

After a Power-on reset, the circuit enters the inactive mode. A minimum number of circuits are active while waiting for the microcontroller to start a session:

- All card contacts are inactive (approximately 200 Ω to GND)
- Pins I/OUC, AUX1UC and AUX2UC are in the high-impedance state (11 kΩ pull-up resistor to V_{DD})
- Voltage generators are stopped
- XTAL oscillator is running
- Voltage supervisor is active
- The internal oscillator is running at its low frequency

8.6 Activation sequence

After power-on and after the internal pulse width delay, the system microcontroller can check the presence of a card using the signals OFF and CMDVCC as shown in Table 5.

Table 5. Card presence indication

OFF	CMDVCC	Indication
HIGH	HIGH	card present
LOW	HIGH	card not present

If the card is in the reader (this is the case if PRES or PRES is active), the system microcontroller can start a card session by pulling CMDVCC LOW. The following sequence then occurs (see Figure 6):

1. CMDVCC is pulled LOW and the internal oscillator changes to its high frequency (t₀).

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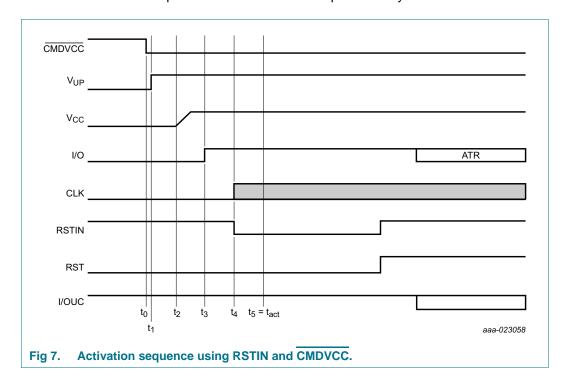
- 2. The voltage doubler is started (between t_0 and t_1).
- 3. V_{CC} rises from 0 to 5 V (or 3 V) with a controlled slope ($t_2 = t_1 + 1.5 \times T$) where T is 64 times the period of the internal oscillator (approximately 25 μ s).
- I/O, AUX1 and AUX2 are enabled (t₃ = t₁ + 4T) (these were pulled LOW until this moment).
- 5. CLK is applied to the C3 contact of the card reader (t₄).
- 6. RST is enabled $(t_5 = t_1 + 7T)$.

The clock may be applied to the card using the following sequence:

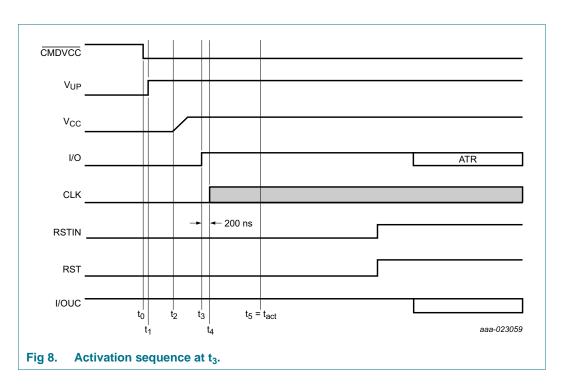
- 1. Set RSTIN HIGH.
- 2. Set CMDVCC LOW.
- 3. Reset RSTIN LOW between t₃ and t₅; CLK will start at this moment.
- 4. RST remains LOW until t₅, when RST is enabled to be the copy of RSTIN.
- 5. After t₅, RSTIN has no further affect on CLK; this allows a precise count of CLK pulses before toggling RST.

If the applied clock is not needed, then $\overline{\text{CMDVCC}}$ may be set LOW with RSTIN LOW. In this case, CLK will start at t_3 (minimum 200 ns after the transition on I/O), and after t_5 , RSTIN may be set HIGH in order to obtain an Answer To Request (ATR) from the card.

Activation should not be performed with RSTIN held permanently HIGH.



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8.7 Active mode

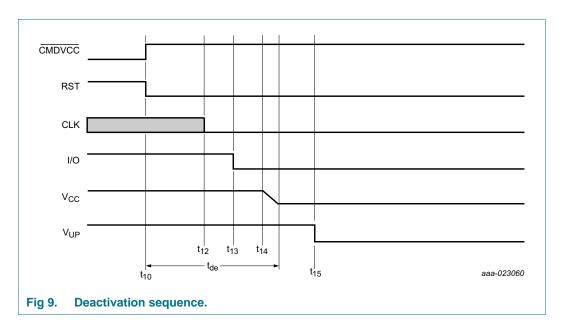
When the activation sequence is completed, the TDA8024 will be in its active mode. Data is exchanged between the card and the microcontroller via the I/O lines. The TDA8024 is designed for cards without V_{PP} (the voltage required to program or erase the internal non-volatile memory).

8.8 Deactive sequence

When a session is completed, the microcontroller sets the $\overline{\text{CMDVCC}}$ line HIGH. The circuit then executes an automatic deactivation sequence by counting the sequencer back and finishing in the inactive mode (see Figure 9):

- 1. RST goes LOW (t₁₀).
- 2. CLK is held LOW ($t_{12} = t_{10} + 0.5 \times T$) where T is 64 times the period of the internal oscillator (approximately 25 μ s).
- 3. I/O, AUX1 and AUX2 are pulled LOW ($t_{13} = t_{10} + T$).
- 4. V_{CC} starts to fall towards zero ($t_{14} = t_{10} + 1.5 \times T$).
- 5. The deactivation sequence is complete at t_{de} , when V_{CC} reaches its inactive state.
- 6. V_{UP} falls to zero (t_{15} = t_{10} + 5T) and all card contacts become low-impedance to GND; I/OUC, AUX1UC and AUX2UC remain at V_{DD} (pulled-up via a 11 k Ω resistor).
- 7. The internal oscillator returns to its lower frequency.

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8.9 V_{CC} generator

The V_{CC} generator has a capacity to supply up to 80 mA continuously at 5 V and 65 mA at 3 V.

An internal overload detector operates at approximately 120 mA. Current samples to the detector are internally filtered, allowing spurious current pulses up to 200 mA with a duration in the order of μ s to be drawn by the card without causing deactivation. The average current must stay below the specified maximum current value.

For reasons of V_{CC} voltage accuracy, a 100 nF capacitor with an ESR < 100 m Ω should be tied to CGND near to pin V_{CC} , and a 100 nF or 220 nF capacitor (220 nF is the best choice) with the same ESR should be tied to CGND near card reader contact C1.

8.10 Fault detection

The following fault conditions are monitored:

- Short-circuit or high current on V_{CC}
- · Removal of a card during a transaction
- V_{DD} dropping
- DC-to-DC converter operating out of the specified values (V_{DDP} too low or current from V_{UP} too high)
- Overheating

There are two different cases (see Figure 10):

CMDVCC HIGH outside a card session. Output OFF is LOW if a card is not in the
card reader, and HIGH if a card is in the reader. A voltage drop on the V_{DD} supply is
detected by the supply supervisor, this generates an internal Power-on reset pulse but
does not act upon OFF. No short-circuit or overheating is detected because the card
is not powered-up.

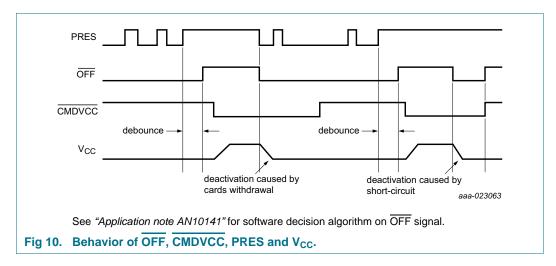
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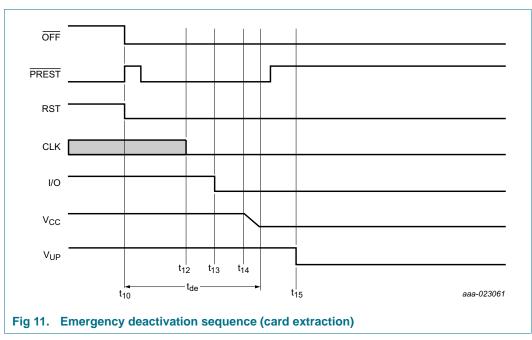
CMDVCC LOW within a card session. Output OFF goes LOW when a fault condition is detected. As soon as this occurs, an emergency deactivation is performed automatically (see Figure 11). When the system controller resets CMDVCC to HIGH it may sense the OFF level again after completing the deactivation sequence. This distinguishes between a hardware problem or a card extraction (OFF goes HIGH again if a card is present).

Depending on the type of card-present switch within the connector (normally-closed or normally-open) and on the mechanical characteristics of the switch, bouncing may occur on the PRES signals at card insertion or withdrawal.

There is a debounce feature in the device with an 8 ms typical duration (see <u>Figure 10</u>). When a card is inserted, output OFF goes HIGH only at the end of the debounce time.

When the card is extracted, an automatic deactivation sequence of the card is performed on the first true/false transition on PRES or PRES and output OFF goes LOW.





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Standard smart card interface

9. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DD}	supply voltage			-0.3	+6.5	V
V_{DDP}	DC-to-DC converter supply voltage			-0.3	+6.5	V
V _I , V _O	voltage on input and output pins	pins XTAL1, XTAL2, 5V/3V, RSTIN, AUX1UC, AUX2UC, I/OUC, CLKDIV1, CLKDIV2, CMDVCC, OFF and PORADJ		-0.3	+6.5	V
V _{card}	voltage on card pins	pins PRES, PRES, I/O, RST, AUX1, AUX2 and CLK		-0.3	+6.5	V
V _n	voltage on other pins	pins V _{UP} , S1 and S2		-0.3	+6.5	V
$T_{j(max)}$	maximum junction temperature			-	150	°C
T _{stg}	storage temperature			-55	+150	°C
V _{ESD}	electrostatic discharge	card contacts in typical application;[1][2]				'
voltage	pins I/O, RST, V_{CC} , AUX1, AUX2, CLK, PRES and PRES		-6	+6	kV	
		all pins;[1]				-
		Human Body Model (HBM)	[2][3]	-2	+2	kV
		Machine Model (MM)	[4]	-200	+200	V

^[1] All card contacts are protected against any short-circuit with any other card contact.

10. Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-a)}	thermal resistance from junction	in free air		
	to ambient		70	K/W
	TDA8024T		70	K/W
	TDA8024AT		100[1]	K/W
	TDA8024TT		1000	IX/VV

^[1] This figure was obtained using the following Printed-Circuit Board (PCB) technology: FR, 4 layers, 0.5 mm thickness, class 5, copper thickness 35 μ m, Ni/Go plating, ground plane in internal layers.

^[2] Every pin withstands the ESD test according to MIL-STD-883C class 3 for card contacts, class 2 for the remaining. Method 3015 (HBM; 1500 Ω and 100 pF) 3 pulses positive and 3 pulses negative on each pin referenced to ground.

^[3] In accordance with EIA/JESD22-A114-B, June 2000.

^[4] In accordance with EIA/JESD22-A115-A, October 1997.

Standard smart card interface

11. Characteristics

 Table 8.
 Characteristics

 $V_{DD} = 3.3 \text{ V}; V_{DDP} = 5 \text{ V}; T_{amb} = 25 \text{ °C}; f_{XTAL} = 10 \text{ MHz}; all currents flowing into the IC are positive: see <u>Table note 1</u>; unless otherwise specified.$

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Temperatur	е		'	'		
T _{amb}	ambient temperature		-25	-	+85	°C
Supplies				-		
V_{DD}	supply voltage		2.7	-	6.5	V
V_{DDP}	DC-to-DC converter	$V_{CC} = 5 \text{ V}; I_{CC} < 80 \text{ mA}$	4.0	5.0	6.5	V
	supply voltage	V _{CC} = 5 V; I _{CC} < 20 mA	3.0	-	6.5	V
I _{DD}	supply current	card inactive	-	-	1.2	mA
		card active; f _{CLK} = f _{XTAL} ; C _L = 30 pF	-	-	1.5	mA
I _{DDP}	DC-to-DC converter supply	inactive mode	-	-	0.1	mA
	current	active mode; $f_{CLK} = f_{XTAL}$; $C_L = 30 \text{ pF}$; $ I_{CC} = 0$	-	-	10	mA
		V _{CC} = 5 V; I _{CC} = 80 mA	-	-	200	mA
		V _{CC} = 3 V; I _{CC} = 65 mA	-	-	100	mA
V _{th2}	falling threshold voltage on V_{DD}	no external resistors at pin PORADJ; V _{DD} level falling	2.35	2.45	2.55	V
V _{hys2}	hysteresis of threshold voltage V _{th2}	no external resistors at pin PORADJ	50	100	150	mV
Pin PORAD)J[2]		<u> </u>	I		I
$V_{th(ext)(rise)}$	external rising threshold voltage on V _{DD}	external resistor bridge at pin PORADJ; V _{DD} level rising	1.240	1.28	1.310	V
$V_{th(ext)(fall)}$	external falling threshold voltage on V _{DD}	external resistor bridge at pin PORADJ; V _{DD} level falling	1.190	1.22	1.26	V
V _{hys(ext)}	hysteresis of threshold voltage Vt _{h(ext)}	external resistor bridge at pin PORADJ	30	60	90	mV
$\Delta V_{\text{hys(ext)}}$	hysteresis of threshold voltage V _{th(ext)} variation with temperature	external resistor bridge at pin PORADJ	-	-	0.25	mV/K
t _w	width of internal Power-on reset pulse	no external resistors at pin PORADJ	4	8	12	ms
		external resistor bridge at pin PORADJ	8	16	24	ms
I _{L(PORADJ)}	leakage current on pin	VPORADJ < 0.5 V	-0.1	4	10	μΑ
	PORADJ	VPORADJ > 1 V	-1	-	+1	μА
P _{tot}	total power dissipation	continuous operation; T _{amb} = -25 to +85 °C	-	-	0.56	W
DC-to-DC c	onverter		1	1	1	1
f _{CLK}	clock frequency	card active	2.2	-	3.2	MHz
V _{th(vd-vf)}	threshold voltage for	5 V card	5.2	5.8	6.2	V
	voltage doubler to change to voltage follower	3 V card	3.8	4.1	4.4	V

Standard smart card interface

 Table 8.
 Characteristics ...continued

 $V_{DD} = 3.3 \text{ V}$; $V_{DDP} = 5 \text{ V}$; $T_{amb} = 25 \text{ °C}$; $f_{XTAL} = 10 \text{ MHz}$; all currents flowing into the IC are positive: see <u>Table note 1</u>; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
V _{UP(av)}	output voltage on pin V _{UP}	V _{CC} = 5 V	5.2	5.7	6.2	V		
	(average value)	V _{CC} = 3 V; V _{DDP} = 3.3 V	3.5	3.9	4.3	V		
Card supply	voltage (pin V _{CC})[3]				•			
C _{VCC}	external capacitance on	[4	80	-	400	nF		
	pin V _{CC}							
V _{CC}	card supply voltage	5 V card						
	(including ripple voltage)	card inactive; I _{CC} = 0 mA	-0.1	0	+0.1	V		
		card inactive; I _{CC} = 1 mA	-0.1	0	+0.3	V		
		card active; I _{CC} < 80 mA	4.75	5.0	5.25	V		
	card active; single current pulse, $I_p = -100 \text{ mA}$; $t_p = 2 \text{ ms}$	4.65	5.0	5.25	V			
	card active; current pulses, I _p = 40 nAs	4.65	5.0	5.25	V			
		card active; current pulses, $I_p = 40$ nAs with $ I_{CC} < 200$ mA; $t_p < 400$ ns	4.65	5.0	5.25	V		
		3 V card						
		card inactive; I _{CC} = 0 mA	-0.1	0	+0.1	V		
		card inactive; I _{CC} = 1 mA	-0.1	0	+0.3	V		
		card active; I _{CC} < 65 mA	2.85	3.0	3.15	V		
		card active; single current pulse, $I_p = -100$ mA; $t_p = 2$ ms	2.76	3.0	3.20	V		
		card active; current pulses, I _p = 40 nAs	2.76	3.0	3.20	V		
		card active; current pulses, $I_p = 40$ nAs with $ I_{CC} < 200$ mA; $t_p < 400$ ns	2.76	3.0	3.20	V		
V _{CC(ripple)(p-p)}	ripple voltage on V _{CC} (peak to peak value)	f _{ripple} = 20 kHz to 200 MHz	-	-	350	mV		
I _{CC}	card supply current	V _{CC} = 0 to 5 V	-	-	80	mA		
		V _{CC} = 0 to 3 V	-	-	65	mA		
		V _{CC} short-circuit to GND	100	120	150	mA		
SR	slew rate	slew up or down	0.08	0.15	0.22	V/µs		
Crystal oscill	ator (pins XTAL1 and XTAL	.2)	1		1	1		
C _{XTAL1} , C _{XTAL2}	external capacitance on pins XTAL1 and XTAL2	depends on type of crystal or resonator used	-	-	15	pF		
: XTAL	crystal frequency		2	-	26	MHz		
XTAL1	frequency applied on pin XTAL1		0	-	26	MHz		
V _{IL}	LOW-level input voltage on pin XTAL1		-0.3	-	+0.3V _{DD}	V		

Standard smart card interface

 Table 8.
 Characteristics ...continued

 $V_{DD} = 3.3 \text{ V}$; $V_{DDP} = 5 \text{ V}$; $T_{amb} = 25 \text{ °C}$; $f_{XTAL} = 10 \text{ MHz}$; all currents flowing into the IC are positive: see <u>Table note 1</u>; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{IH}	HIGH-level input voltage on pin XTAL1		0.7V _{DD}	-	V _{DD} + 0.3	V
Data lines (pins I/O, I/OUC, AUX1, AUX2	AUX1UC and AUX2UC)	'		'	
t _{d(I/O-I/OUC)} , t _{d(I/OUC-I/O)}	I/O to I/OUC, I/OUC to I/O falling edge delay		-	-	200	ns
t _{pu}	active pull-up pulse width		-	-	100	ns
f _{I/O(max)}	maximum frequency on data lines		-	-	1	MHz
Ci	input capacitance on data lines		-	-	10	pF
Data lines t	o card reader (pins I/O, AUX1	and AUX2; with integrated 11	kΩ pull-up res	sistors to	V _{CC})	
V _{o(inactive)}	output voltage	inactive mode				
		no load	0	-	0.1	V
		I _{o(inactive)} = 1 mA	-	-	0.3	V
I _{o(inactive)}	output current	inactive mode; pin grounded	-	-	-1	mA
V _{OL}	LOW-level output voltage	I _{OL} = 1 mA	0	-	0.3	V
		$I_{OL} \ge 15 \text{ mA}$	V _{CC} - 0.4	-	V _{CC}	V
V _{OH}	HIGH-level output voltage	no DC load	0.9V _{CC}	-	V _{CC} + 0.1	V
		5 V and 3 V cards; I _{OH} < -40 μA	0.75V _{CC}	-	V _{CC} + 0.1	V
		$ I_{OH} \ge 10 \text{ mA}$	0	-	0.4	V
V _{IL}	LOW-level input voltage		0.3	-	0.8	V
V _{IH}	HIGH-level input voltage		1.5	-	V _{CC} + 0.3	V
I _{IL}	LOW-level input current	V _{IL} = 0 V	-	-	600	μΑ
I _{LIH}	HIGH-level input leakage current	$V_{IH} = V_{CC}$	-	-	10	μА
$t_{t(DI)}$	data input transition time	V _{IL(max)} to V _{IH(min)}	-	-	1.2	μS
$t_{t(DO)}$	data output transition time	$V_o = 0 \text{ to } V_{CC}; C_L \le 80 \text{ pF};$ 10% to 90%	-	-	0.1	μS
R _{pu}	integrated pull-up resistor	pull-up resistor to V _{DD}	9	11	13	kΩ
I _{pu}	current when pull-up active	$V_{OH} = 0.9V_{CC}$; C = 80 pF	-1	-	-	mA
Data lines to	o microcontroller (pins I/OU	C, AUX1UC and AUX2UC; with	integrated 11	kΩ pull-u	p resistors to	V _{DD})
V _{OL}	LOW-level output voltage	I _{OL} = 1 mA	0	-	0.3	V
V _{OH}	HIGH-level output voltage	no DC load	0.9V _{DD}	-	V _{DD} + 0.1	V
		5 V and 3 V cards; I _{OH} < –40 μA	0.75V _{DD}	-	V _{DD} + 0.1	V
V _{IL}	LOW-level input voltage		-0.3	-	+0.3V _{DD}	V
V _{IH}	HIGH-level input voltage		0.7V _{DD}	-	V _{DD} + 0.3	V
I _{LIH}	HIGH-level input leakage current	$V_{IH} = V_{DD}$	-	-	10	μА
I _{IL}	LOW-level input current	V _{IL} = 0 V	-	-	600	μΑ
$t_{t(DI)}$	data input transition time	V _{IL(max)} to V _{IH(min)}	-	-	1.2	μS

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 Table 8.
 Characteristics ...continued

 $V_{DD} = 3.3 \text{ V}$; $V_{DDP} = 5 \text{ V}$; $T_{amb} = 25 \text{ °C}$; $f_{XTAL} = 10 \text{ MHz}$; all currents flowing into the IC are positive: see <u>Table note 1</u>; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$t_{t(DO)}$	data output transition time	V _o = 0 to V _{DD} ; C _L < 30 pF; 10% to 90%	-	-	0.1	μS
R _{pu}	integrated pull-up resistor	pull-up resistor to V _{DD}	9	11	13	kΩ
I _{pu}	current when pull-up active	$V_{OH} = 0.9V_{DD}$; C = 30 pF	-1	-	-	mA
Internal osci	llator					
f _{OSC(int)}	frequency of internal	inactive mode	55	140	200	kHz
	oscillator	active mode	2.2	2.7	3.2	MHz
Reset output	to card reader (pin RST)			-		
V _{o(inactive)}	output voltage	inactive mode				
		no load	0	-	0.1	V
		I _{o(inactive)} = 1 mA	0	-	0.3	V
I _{o(inactive)}	output current	inactive mode; pin grounded	-	-	-1	mA
t _{d(RSTIN-RST)}	RSTIN to RST delay	RST enabled	-	-	2	μS
V _{OL}	LOW-level output voltage	I _{OL} = 200 μA	0	-	0.2	V
		I _{OL} = 20 mA (current limit)	$V_{CC}-0.4$	-	V _{CC}	V
V _{OH}	HIGH-level output voltage	I _{OH} = -200 μA	0.9V _{CC}	-	V _{CC}	V
		I _{OH} = −20 mA (current limit)	0	-	0.4	V
t _r	rise time	C _L = 100 pF; V _{CC} = 5 V or 3 V	-	-	0.1	μS
t _f	fall time	C _L = 100 pF; V _{CC} = 5 V or 3 V	-	-	0.1	μS
Clock output	to card reader (pin CLK)			•	·	
V _{o(inactive)}	output voltage	inactive mode				
		no load	0	-	0.1	V
		I _{o(inactive)} = 1 mA	0	-	0.3	V
I _{o(inactive)}	output current	CLK inactive; pin grounded	0	-	-1	mA
V _{OL}	LOW-level output voltage	I _{OL} = 200 μA	0	-	0.3	V
		I _{OL} = 70 mA (current limit)	$V_{CC}-0.4$	-	V _{CC}	V
V _{OH}	HIGH-level output voltage	$I_{OH} = -200 \mu A$	0.9V _{CC}	-	V _{CC}	V
		I _{OH} = -70 mA (current limit)	0	-	0.4	V
t _r	rise time	$C_L = 30 \text{ pF}$ [5]	-	-	16	ns
t _f	fall time	$C_L = 30 \text{ pF}$ [5]	-	-	16	ns
δ	duty factor (except for f_{XTAL})	$C_L = 30 \text{ pF}$ [5]	45	-	55	%
SR	slew rate	slew up or down; C _L = 30 pF	0.2	-	-	V/ns
Control inpu	ts (pins CLKDIV1, CLKDIV2	, CMDVCC, RSTIN and 5V/3V)[6]				
VIL	LOW-level input voltage	-	-0.3	-	+0.3V _{DD}	V
Vih	HIGH-level input voltage		0.7V _{DD}	-	V _{DD} + 0.3	V
I _{LIL}	LOW-level input leakage current	$0 < V_{IL} < V_{DD}$	-	-	1	μА
l _{LiH}	HIGH-level input leakage current	$0 < V_{IH} < V_{DD}$	-	-	1	μА

Product data sheet

Standard smart card interface

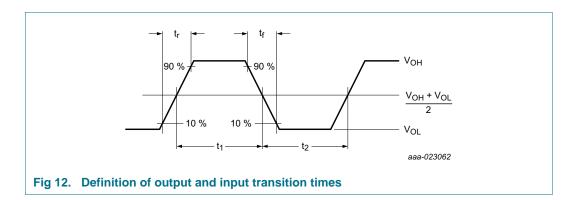
Table 8. Characteristics ... continued

 $V_{DD} = 3.3 \text{ V}; V_{DDP} = 5 \text{ V}; T_{amb} = 25 \text{ °C}; f_{XTAL} = 10 \text{ MHz}; all currents flowing into the IC are positive: see <u>Table note 1</u>; unless otherwise specified.$

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Card prese	ence inputs (pins PRES and P	RES)[7]				·
VIL	LOW-level input voltage		-0.3	-	+0.3V _{DD}	V
ViH	HIGH-level input voltage		0.7V _{DD}	-	V _{DD} + 0.3	V
I _{LIL}	LOW-level input leakage current	$0 < V_{IL} < V_{DD}$	-	-	5	μА
l _{LiH}	HIGH-level input leakage current	$0 < V_{IH} < V_{DD}$	-	-	5	μА
Interrupt o	utput (pin OFF; NMOS drain v	with integrated 20 kΩ pull-up re	sistor to V _{DD}))		
V_{OL}	LOW-level output voltage	$I_{OL} = 2 \text{ mA}$	0	-	0.3	V
V _{OH}	HIGH-level output voltage	$I_{OH} = -15 \mu A$	0.75V _{DD}	-	-	V
R _{pu}	integrated pull-up resistor	20 kΩ pull-up resistor to V_{DD}	16	20	24	kΩ
Protection	and limitation					
$ I_{CC(sd)} $	shutdown and limitation current pin V _{CC}		-	130	150	mA
I _{I/O(lim)}	limitation current pins I/O, AUX1 and AUX2		-15	-	+15	mA
I _{CLK(lim)}	limitation current pin CLK		-70	-	+70	mA
I _{RST(lim)}	limitation current pin RST		-20	-	+20	mA
T _{sd}	shut-down temperature		-	150	-	°C
Timing						
t _{act}	activation time	see Figure 7	50	-	220	μS
t _{de}	deactivation time	see Figure 8	50	80	100	μS
t ₃	start of the window for sending CLK to the card	see Figure 7	50	-	130	μS
t ₅	end of the window for sending CLK to the card	see <u>Figure 7</u>	140	-	220	μS
t _{debounce}	debounce time pins PRES and PRES	see Figure 10	5	8	11	ms

- [1] All parameters remain within limits but are tested only statistically for the temperature range. When a parameter is specified as a function of V_{DD} or V_{CC} it means their actual value at the moment of measurement.
- [2] If no external bridge is used then, to avoid any disturbance, it is recommended to connect pin 18 to ground. Pin 18 is not connected in the TDA8024AT.
- [3] To meet these specifications, pin V_{CC} should be decoupled to CGND using two ceramic multilayer capacitors of low ESR both with values of 100 nF, or one 100 nF and one 220 nF (see Figure 13).
- [4] Permitted capacitor values are 100 nF, or 100 nF + 100 nF, or 220 nF, or 220 nF + 100 nF, or 330 nF.
- [5] Transition time and duty factor definitions are shown in Figure 12; $\delta = \frac{t_1}{t_1 + t_2}$
- [6] Pin CMDVCC is active LOW; pin RSTIN is active HIGH; for CLKDIV1 and CLKDIV2 functions see Table 1.
- [7] Pin PRES is active LOW; pin PRES is active HIGH; PRES has an integrated 1.25 μA current source to GND (PRES to V_{DD}); the card is considered present if at least one of the inputs PRES or PRES is active.

Standard smart card interface



12. Application information

Performance can be affected by the layout of the application. For example, an additional cross-capacitance of 1 pF between card reader contacts C2 and C3 or C2 and C7 can cause contact C2 to be polluted with high frequency noise from C3 (or C7). In this case, include a 100 pF capacitor between contacts C2 and CGND.

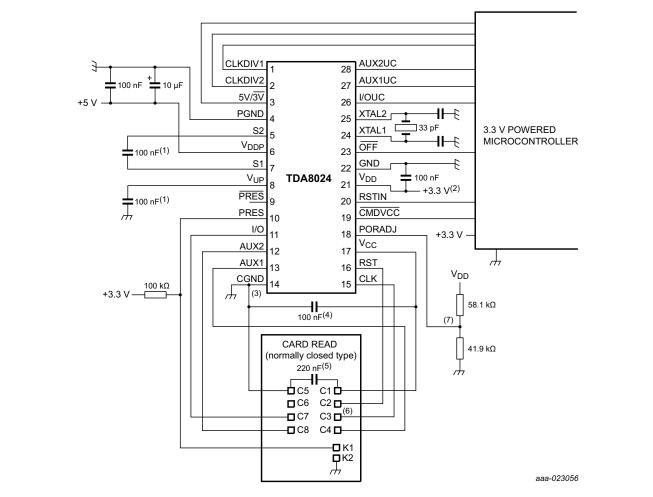
Application recommendations:

- Ensure there is ample ground area around the TDA8024 and the connector; place the TDA8024 very near to the connector; decouple the V_{DD} and V_{DDP} lines (these lines are best positioned under the connector)
- The TDA8024 and the microcontroller must use the same V_{DD} supply. Pins CLKDIV1, CLKDIV2, RSTIN, PRES, PRES, AUX1UC, I/OUC, AUX2UC, 5V/3V, CMDVCC, and OFF are referred to V_{DD}; if pin XTAL1 is to be driven by an external clock, also refer this pin to V_{DD}
- Track C3 should be placed as far as possible from the other tracks
- The track connecting CGND to C5 should be straight (the two capacitors on C1 should be connected to this ground track)
- Avoid ground loops between CGND, PGND and GND
- Decouple V_{DDP} and V_{DD} separately; if the two supplies are the same in the application, then they should be connected in star on the main track.

With all these layout precautions, noise should be kept to an acceptable level and jitter on C3 should be less than 100 ps.

Reference layouts are provided in "Application note 10141", available on request.

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- (1) These capacitors must be of the low ESR-type and be placed near the IC (within 100 mm).
- (2) TDA8024 and the microcontroller must use the same V_{DD} supply.
- (3) Make short, straight connections between CGND, C5 and the ground connection to the capacitor.
- (4) Mount one low ESR-type 100 nF capacitor close to pin V_{CC} .
- (5) Mount one low ESR-type 100 or 220 nF capacitor close to C1 contact (less than 100 mm from it).
- (6) The connection to C3 should be routed as far from C2, C7, C4 and C8 and, if possible, surrounded by grounded tracks.
- (7) Optional resistor bridge for changing the threshold of V_{DD}. If this bridge is not required pin 18 should be connected to ground; see Section 8.2.2. Pin 18 is not connected in the TDA8024AT.

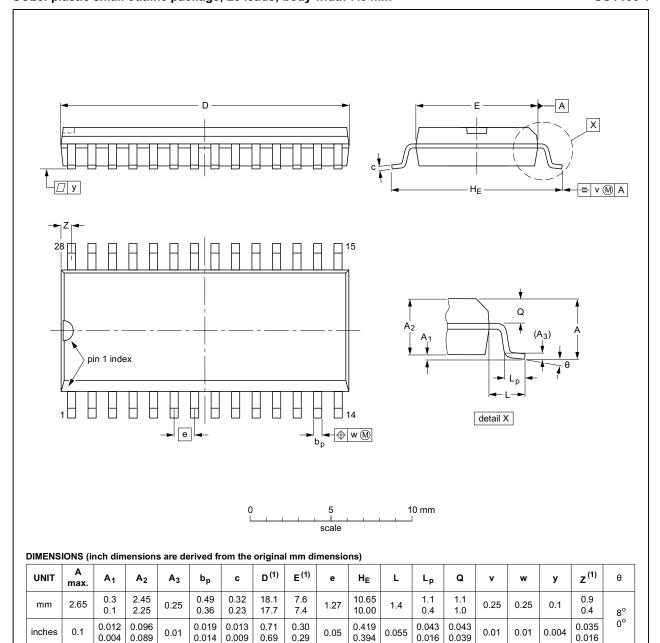
Fig 13. Application diagram

Standard smart card interface

13. Package outline

SO28: plastic small outline package; 28 leads; body width 7.5 mm

SOT136-1



Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE VERSION		REFER	EUROPEAN	ISSUE DATE		
	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT136-1	075E06	MS-013				99-12-27 03-02-19

Fig 14. Package outline SOT136-1 (SO28)

TDA8024

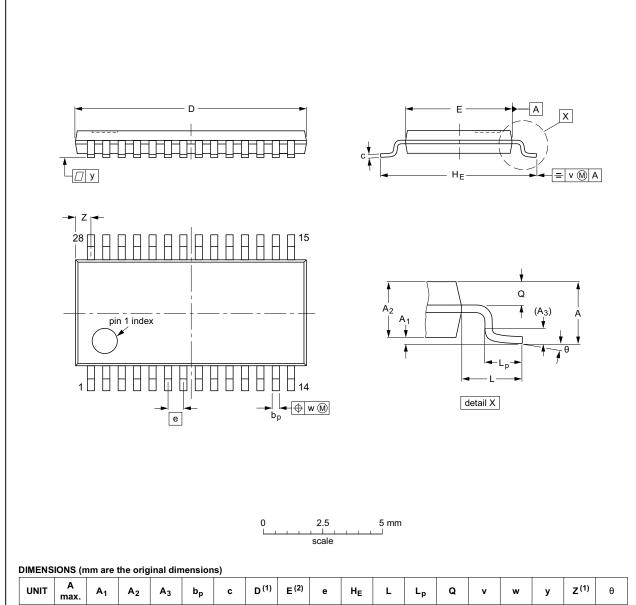
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Standard smart card interface

TSSOP28: plastic thin shrink small outline package; 28 leads; body width 4.4 mm

SOT361-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E (2)	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	9.8 9.6	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.8 0.5	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

	REFER	EUROPEAN	ISSUE DATE			
IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
	MO-153				99-12-27 03-02-19	
	IEC				IEC JEDEC JEITA PROJECTION	

Fig 15. Package outline SOT361-1 (TSSOP28)

TDA8024

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Standard smart card interface

14. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365* "Surface mount reflow soldering description".

14.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

14.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- · Board specifications, including the board finish, solder masks and vias
- · Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

14.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

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14.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 16</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 9 and 10

Table 9. SnPb eutectic process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)				
	Volume (mm³)				
	< 350	≥ 350			
< 2.5	235	220			
≥ 2.5	220	220			

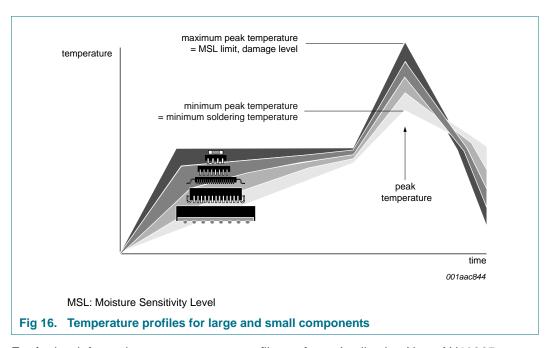
Table 10. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)						
	Volume (mm³)						
	< 350	350 to 2000	> 2000				
< 1.6	260	260	260				
1.6 to 2.5	260	250	245				
> 2.5	250	245	245				

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 16.

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For further information on temperature profiles, refer to Application Note *AN10365* "Surface mount reflow soldering description".

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15. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes			
TDA8024 v.4.0	20160603	Product data sheet	-	TDA8024_3			
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 						
	 Legal texts ha 	ive been adapted to the new c	ompany name where	e appropriate.			
	Section 5 "Ordering information": updated						
TDA8024_3	20040712	Product specification	-	TDA8024_2			
TDA8024_2	20030819	Product specification	-	-			

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16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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